## Notice of References Cited 10/796,739 Reexamination BOWDEN ET AL. Examiner Laura S Weiner 1745 Reexamination BOWDEN ET AL. Page 1 of 1

Application/Control No.

Applicant(s)/Patent Under

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
-	Α	US-5,316,877	05-1994	Thackeray et al.	429/224
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63-187569	08-1988	Japan	Furukawa et al.	
	0				Patent and abstract	
	Р					
	Q					
	R					
	S					
	Т			c.		

## **NON-PATENT DOCUMENTS**

	г —	
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	IJ	
	<b>V</b>	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.